

**Search Notes**

Application/Control No.

10/614,744

Examiner

Chuck Huynh

Applicant(s)/Patent under  
Reexamination

HICKS ET AL.

Art Unit

2683

**SEARCHED**

Class	Subclass	Date	Examiner
Update	Search	1/21/2006	CH
455	466	1/21/2006	CH
379	93.9	1/21/2006	CH
370	401	1/21/2006	CH
370	276	1/21/2006	CH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	1/21/2006	CH
Combined Text	1/21/2006	CH
IDS	1/20/2006	CH